

Notice of References Cited	Application/Control No. 10/062,700		Applicant(s)/Patent Under Reexamination LAU ET AL.	
	Examiner Djenane M. Bayard		Art Unit 2141	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,834,054	12-2004	Dumortier et al.	370/395.5
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*	C	US-2002/0143935	10-2002	Schenkel et al.	709/224
*	D	US-2002/0159458	10-2002	Foster et al.	370/392
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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